Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/607,784	UENAKA ET AL.	
Examiner	Art Unit	
Daquan Zhao	2621	

	SEAR	CHED	
Class	Subclass	Date	Examiner
386	1,45,46	3/24/2007	DZ
	65,95	3/24/2007	DZ
	125-126	3/24/2007	DZ
			-

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT; USPGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see search note attached)	3/24/2007	DZ		
consult with Thai Tran for searching	3/24/2007	dz		
see search note for inventor name search	3/24/2007	DZ		
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